# In Situ Resistivity Measurement of Metal Surfaces to Track Down Dislocations Caused by High Field Conditioning

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#### Introduction

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- **Surface Conditioning:** Progressive development of resistance to vacuum arcing over the operational life of a high gradient system
- **Hypothesis:** Sharp features form on the surface due to the collective activity of the dislocations within the surface layer of the sample [1]. During conditioning, new dislocations are created → increase in resistivity near the surface (we can measure this!)
- **Cryogenic Measurements:** At temperatures of a few kelvin, the resistivity is given only by the scattering of the electrons off the lattice defects
- Sensitivity to a thin layer near the surface: At GHz frequencies, the current penetrates only a few um in the copper sample at room temperature (skin effect) → we can measure the resistivity only near the surface by using RF methods

Aim: test the hypothesis by measuring the surface resistivity during the conditioning process using RF methods in cryogenic conditions.

#### Method

• Information about the resistivity from the **quality factor** of the resonant system, obtained by fitting the Q-circle (Fig. 1) [2]  $Q = \frac{G}{2} - \frac{G}{2}$ 

 $Q_0 = \frac{G}{R_S} \qquad R_S = \sqrt{\frac{\omega\mu\rho}{2}}$ 

- But, at cryogenic temperatures, we have the anomalous skin effect [3]
- At cryogenic temperatures, the skin depth (0.1 um) is much smaller than the mean free path (4.2 um)
- Most conduction band electrons will not suffer any collisions in the skin depth and they will penetrate deeper into the material. We are sensitive to changes in resistivity ~1 um underneath the surface
- Calculation for Rs is more complicated: we have small changes in Rs even for a big change in  $\rho$  (Fig. 2)





### Testing the first design

- The first design was manufactured in Uppsala University's workshop
- The design was tested at room temperature
- Measured frequency: 3.7 GHz
- Gap Size: 75 um,  $Q_0 = 75$ , very close to the values obtained from simulations
- How can we be sure that we coupled to the correct mode and not to the parasitic mode? Make transmission measurements: antennas 180 degrees apart significant transmission, antennas 90 degrees apart little transmission







*Fig. 13.* The modified anode (1st design), with the antennas used for testing the design (left and center) and the S-parameters measured in transmission configuration (right)

## Conclusions

- We propose making surface resistivity measurements during high-field conditioning to test the dislocation hypothesis
- Cryogenic conditions, DC conditioning, RF resistivity measurement
- Slight issue: the anomalous skin effect
- The current electrode system needs to be modified in order to contain a resonant mode between electrodes
- We have proposed two designs
- First design:
  - Only the anode is modified
  - Notches, more complicated design
  - Electrical contact issues
- Second Design:
  - Both electrodes are modified
  - Simpler design
  - No issues with electrical contact
- We have tested the first design at room temperature: it works as expected!
- Next steps: test the second design, make RF resistivity measurements in cryogenic conditions during conditioning
- These designs might also be used for novel methods of investigating RF breakdowns.



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